


<b>Search Notes</b>  	<b>Application/Control No.</b>  10644188	<b>Applicant(s)/Patent Under Reexamination</b>  ROTBOLL ET AL.
	<b>Examiner</b>  ERIC PICO	<b>Art Unit</b>  3654

SEARCHED			
Class	Subclass	Date	Examiner
187	401-403	7/28/2005	EEP
414	241, 243	7/28/2005	EEP
187	272-275	2/2/2007	EEP

SEARCH NOTES		
Search Notes	Date	Examiner
Class 187 Consulted Thuy Tran	7/28/2005	EEP
Class 414 Consulted James Keenan	7/28/2005	EEP
EAST Search History Attached	7/28/2005	EEP
Updated EAST Search History Attached	1/30/2006	EEP
Updated EAST Search History Attached	7/11/2006	EEP
Updated EAST Search History Attached	2/2/2007	EEP
Updated EAST Search History Attached	7/25/2007	EEP
Updated EAST Search History Attached	3/14/2008	EEP
Updated EAST Search History Attached	11/20/2008	EEP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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